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X	AA	4,483,194	November 20, 1984	Rudolf	Rudolf			_				
V.	AB	6,122,965	September 26, 2000	Seidel et al.				- <u>-</u>				
X	AC	5,065,628	November 19, 1991	Benecke								
V.	AD	5,831,164	November 3, 1998	Reddi et al.								
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